Search Notes

Application/Control No.	

Applicant(s)/Patent under Reexamination

10/849,319 Examiner

Naheed Ejaz

CHANG ET AL. Art Unit

2611

SEARCHED				
Class	Subclass	Date	Examiner	
375	354,355, 371,373, 375,376	8/16/2007	NE	
327	100,141	8/16/2007	NE	
327	144,147	8/16/2007	NE	
327	156,365	8/16/2007	NE	
327	407,291	8/16/2007	NE	
327	298	8/16/2007	NE .	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			,	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST search attached	8/7/2007	NE	
Consulted with SPE Chieh M. Fan	8/7/2007	NE	